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| Search Notes | Application/Control No. | Applicant(s)/Patent Under Reexamination |
| | 10676800 | BERNAL ET AL. |
|  | Examiner | Art Unit |
| | Myint, Dennis | 2162 |

| SEARCHED | | | |
|-----------------|-----------------|-------------|-----------------|
| Class | Subclass | Date | Examiner |
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| SEARCH NOTES | | |
|---|-------------|-----------------|
| Search Notes | Date | Examiner |
| EAST (EPO; JPO; IBM; USPAT; USPGPUB) , attached | 10/23/2007 | DM |
| EAST (EPO; JPO; IBM; USPAT; USPGPUB) , attached | 12/05/2007 | DM |
| EAST (EPO; JPO; IBM; USPAT; USPGPUB) , attached | 12/06/2007 | DM |
| STIC (EIC) Search, attached | 09/05/2007 | Wasseem Hamdan |
| 707/100 limited with keywords , attached | 12/06/2007 | DM |
| NPL: ACM database search, attached | 12/07/2007 | DM |
| NPL: IEEE database search , attached | 12/07/2007 | DM |
| NPL: Google Scholar search , attached | 12/07/2007 | DM |
| EAST (EPO; JPO; IBM; USPAT; USPGPUB) , attached | 5/8/2008 | DM |
| 707/100 limited with keywords , attached | 5/8/2008 | DM |
| NPL: ACM database search, attached | 5/8/2008 | DM |
| NPL: IEEE database search , attached | 5/8/2008 | DM |
| NPL: Google Scholar search , attached | 5/8/2008 | DM |

| INTERFERENCE SEARCH | | | |
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| Class | Subclass | Date | Examiner |
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